TOSHIBA PHOTOCOUPLER GaAs IRED & PHOTO-TRIAC

TLP3041(S),TLP3042(S),TLP3043(S)

OFFICE MACHINE
HOUSEHOLD USE EQUIPMENT
TRIAC DRIVER
SOLID STATE RELAY

The TOSHIBA TLP3041 (S), TLP3042 (S), TLP3043 (S) consist of a zero voltage crossing turn-on photo-triac optically coupled to a gallium arsenide infrared emitting diode in a six lead plastic DIP package.
All parameters are tested to the specification of TLP3041, TLP3042, TLP3043.

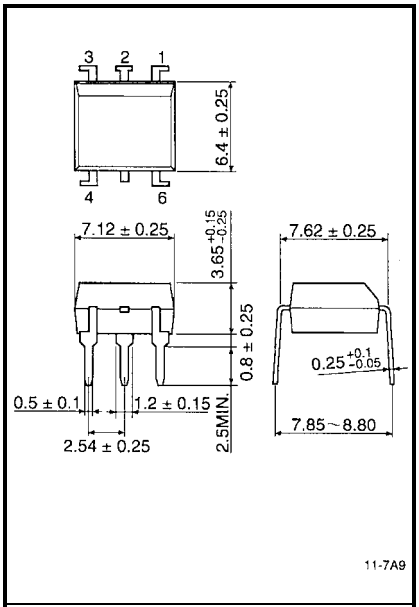
- Peak Off-State Voltage : 400 V (min)
- Trigger LED Current : 15 mA (max) (TLP3041)
  10 mA (max) (TLP3042)
  5 mA (max) (TLP3043)
- On-State Current : 100 mA (max)
- UL Recognized : UL1577, File No. E67349
- Isolation Voltage : 5000 Vrms (min)
- Option (D4) Type
  VDE Approved : DIN VDE0884 / 06.92
  Certificate No. 68329
  Maximum Operating Insulation Voltage : 890 Vpk
  Highest Permissible Over Voltage : 8000 Vpk

Note: When a VDE0884 approved type is needed,please designate the "Option (D4) "

- Device Construction

	7.62mm pich standard type	10.16 mm pich (LF2) type
Creepage Distance	7.0 mm (min)	8.0 mm (min)
Clearance	7.0 mm (min)	8.0 mm (min)
Insulation Thickness	0.5 mm (min)	0.5 mm (min)

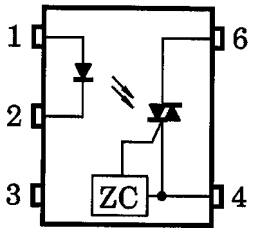
Unit: mm



JEDEC	—
EIAJ	—
TOSHIBA	11-7A9

weight: 0.39g

PIN CONFIGURATION (Top view)



1: ANODE
2: CATHODE
3: N.C.
4: TERMINAL 1
6: TERMINAL 2

MAXIMUM RATINGS (Ta = 25°C)

CHARACTERISTIC			SYMBOL	RATING	UNIT
LED	Forward Current		I_F	50	mA
	Forward Current Derating (Ta ≥ 53°C)		ΔI_F / °C	−0.7	mA / °C
	Peak Forward Current (100μs pulse, 100pps)		I_{FP}	1	A
	Power Dissipation		P_D	100	mW
	Power Dissipation Derating (Ta ≥ 25°C)		ΔP_D / °C	−1.0	mW / °C
	Reverse Voltage		V_R	5	V
	Junction Temperature		T_j	125	°C
DETECTOR	Off-State Output Terminal Voltage		V_{DRM}	400	V
	On-Stage RMS Current	Ta = 25°C	$I_{T(RMS)}$	100	mA
		Ta = 70°C		50	
	On-State Current Derating (Ta ≥ 25°C)		ΔI_T / °C	−1.1	mA / °C
	Peak On-Stage Current (100μs pulse, 120pps)		I_{TP}	2	A
	Peak Nonrepetitive Surge Current (P_W = 10ms, DC = 10%)		I_{TSM}	1.2	A
	Power Dissipation		P_D	300	mW
	Power Dissipation Derating (Ta ≥ 25°C)		ΔP_D / °C	−4.0	mW / °C
	Junction Temperature		T_j	115	°C
Storage Temperature Range			T_{stg}	−55 ~ 150	°C
Operating Temperature Range			T_{opr}	−40 ~ 100	°C
Lead Soldering Temperature (10s)			T_{sol}	260	°C
Total Package Power Dissipation			P_T	330	mW
Total Package Power Dissipation Derating (Ta ≥ 25°C)			ΔP_T / °C	−4.4	mW / °C
Isolation Voltage (AC, 1 min., R.H. ≤ 60%) (Note 1)			BV_S	5000	Vrms

Note 1: Device considered a two terminal device: Pins 1, 2 and 3 shorted together and pins 4 and 6 shorted together.

RECOMMENDED OPERATING CONDISTIONS

CHARACTERISTIC	SYMBOL	MIN	TYP.	MAX	UNIT
Supply Voltage	V_{AC}	—	—	120	Vac
Forward Current	I_F*	15	20	25	mA
Peak On-Stage Current	I_{TP}	—	—	1	A
Operating Temperature	T_{opr}	−25	—	85	°C

* : In the case of TLP3042

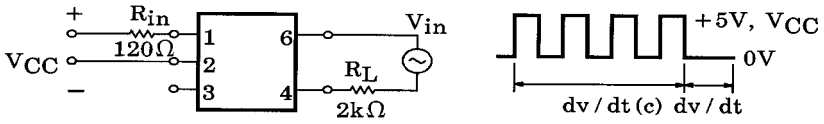
INDIVIDUAL ELECTRICAL CHARACTERISTICS (Ta = 25°C)

	CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
LED	Forward Voltage	V_F	I_F = 10mA	1.0	1.15	1.3	V
	Reverse Current	I_R	V_R = 5V	—	—	10	μA
	Capacitance	C_T	V = 0, f = 1MHz	—	10	—	pF
DETECTOR	Peak Off-State Current	I_{DRM}	V_{DRM} = 400V	—	10	100	nA
	Peak On-Stage Voltage	V_{TM}	I_{TM} = 100mA	—	1.7	3.0	V
	Holding Current	I_H	—	—	0.6	—	mA
	Critical Rate of Rise of Off-State Voltage	dv / dt	V_{in} = 120Vrms, Ta = 85°C (Fig.1)	200	500	—	V / μs
	Critical Rate of Rise of Commutating Voltage	dv / dt(c)	V_{in} = 30Vrms, IT = 15mA (Fig.1)	—	0.2	—	V / μs

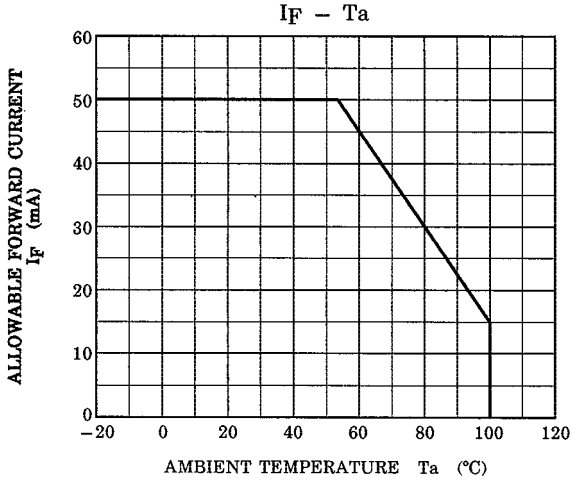
COUPLED ELECTRICAL CHARACTERISTICS (Ta = 25°C)

CHARACTERISTIC		SYMBOL	TEST CONDITION	MIN	TYP.	MAX	UNIT
Trigger LED Current	TLP3041	I_{FT}	V_T = 3V	—	—	15	mA
	TLP3042			—	5	10	
	TLP3043			—	—	5	
Inhibit Voltage		V_{IH}	I_F = Rated I_{FT}	—	—	40	V
Leakage in Inhibited State		I_{IH}	I_F = Rated I_{FT} V_T = Rated V_{DRM}	—	100	300	μA
Capacitance Input to Output		C_S	V_S = 0, f = 1MHz	—	0.8	—	pF
Isolation Resistance		R_S	V_S = 500V (R.H. ≤ 60%)	5×10^{10}	10^{14}	—	Ω
Isolation Voltage		BV_S	AC, 1 minute	5000	—	—	Vrms
			AC, 1 second (in oil)	—	10000	—	
			DC, 1 minute (in oil)	—	10000	—	Vdc

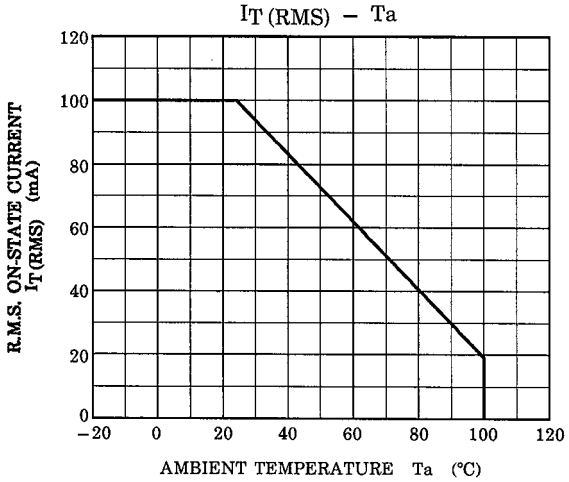
Fig. 1 dv / dt TEST CIRCUIT



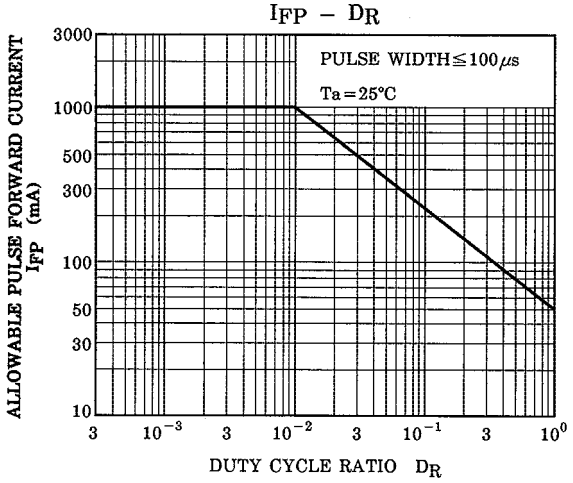
I_F – Ta



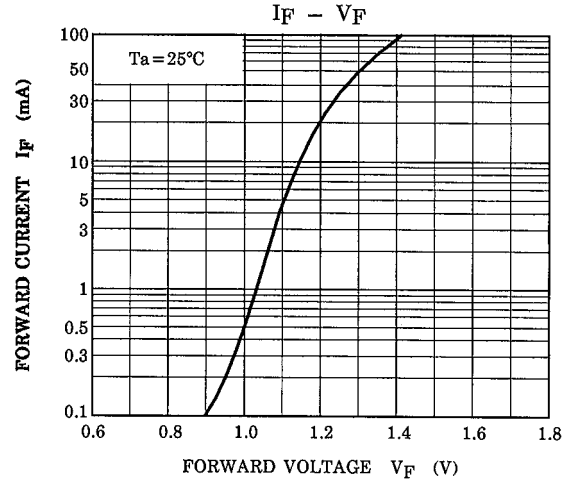
$I_{T(RMS)}$ – Ta



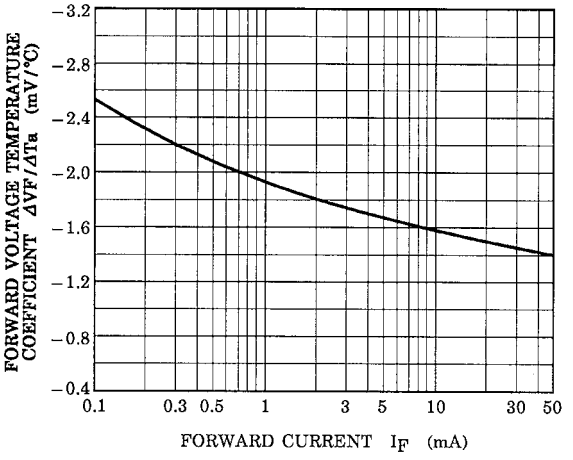
I_{FP} – D_R



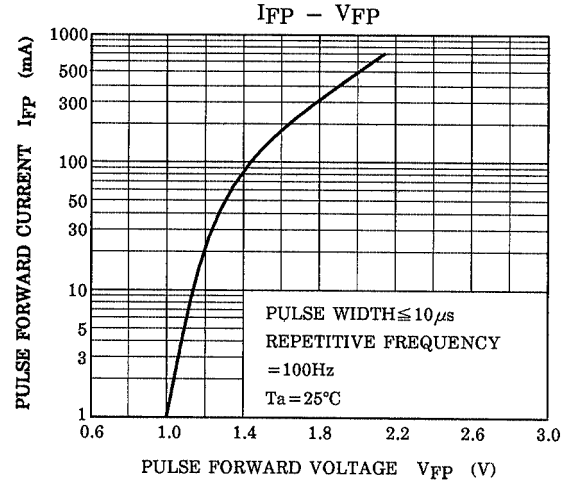
I_F – V_F



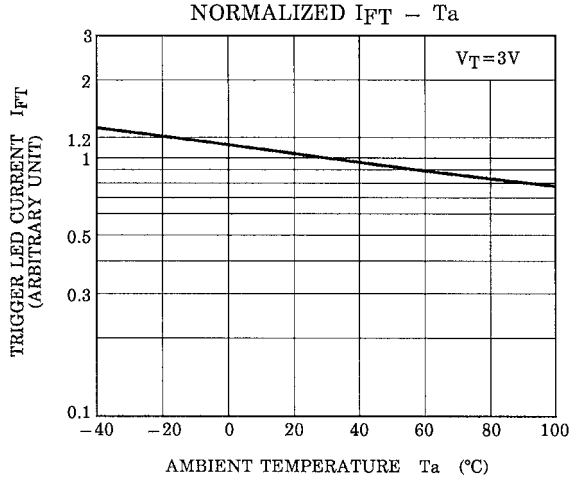
$\Delta V_F / \Delta Ta$ – I_F



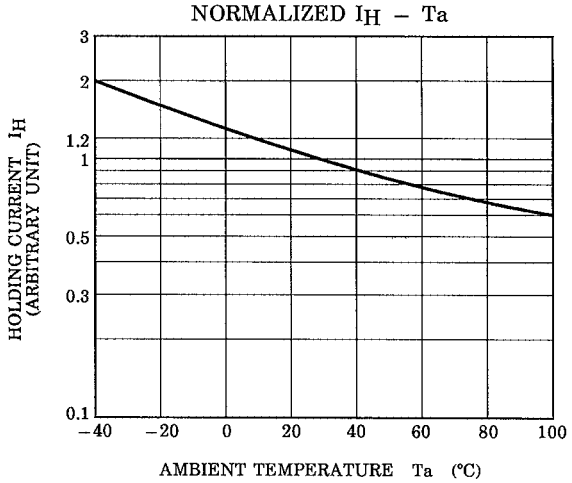
I_{FP} – V_{FP}



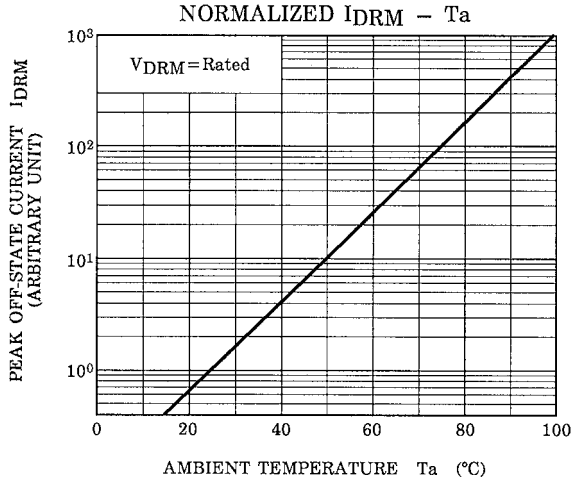
NORMALIZED I_{FT} – Ta



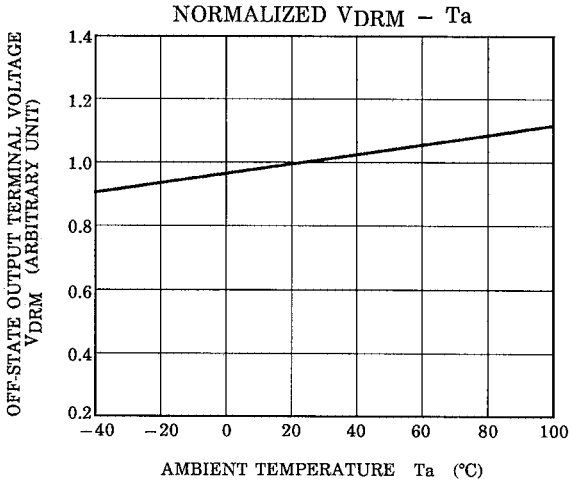
NORMALIZED I_H – Ta



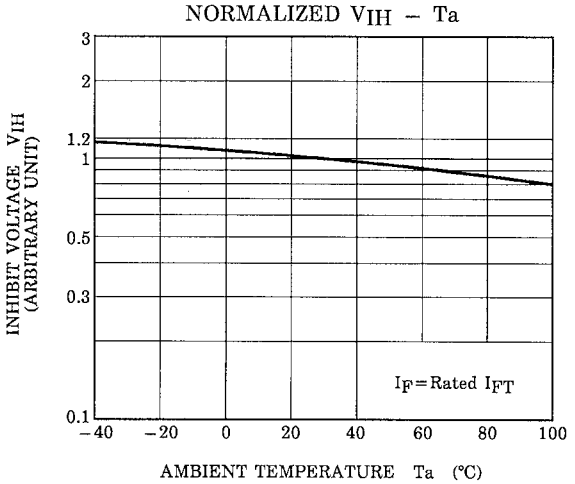
NORMALIZED I_{DRM} – Ta



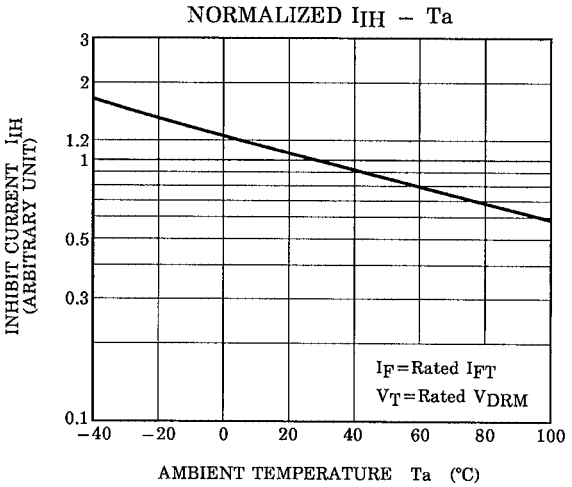
NORMALIZED V_{DRM} – Ta



NORMALIZED V_{IH} – Ta



NORMALIZED I_{IH} – Ta



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